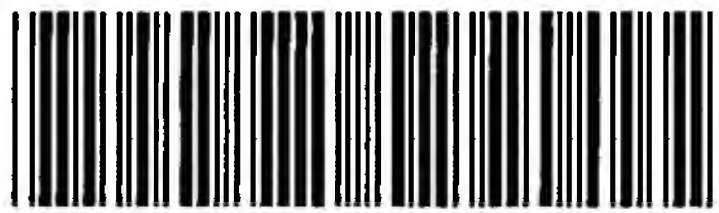



<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/734,159	TWIG ET AL.	
	Examiner	Art Unit	
	Susan Y. Chen	2161	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated text search on East DB for classes/subclasses: 707/2, 3, 7, 200; 709/217, 223, 229; 705/52, 57; 715/738	10/30/2007	TYC
Palm inventor search	10/30/2007	TYC

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